Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	11	("702"/\$.ccls. "706"/\$.ccls. "709"/\$.ccls. "710"/\$.ccls. "713"/\$.ccls. "714"/\$.ccls. "324"/\$.ccls. "365"/\$.ccls.) and (test\$3 with component with electronic) and (margin with test\$3) and (indicat\$4 identif\$4) with fault) and pass and fail	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 13:55
S25 3	12	(test\$3 with component with electronic) and (margin with test\$3) and ((indicat\$4 identif\$4) with fault) and pass and fail	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 13:54
S27 6	0	S272 and (transmit\$4 with fault with signal with power with control\$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 12:21
S27 5	1	S272 and (power with control\$4) and (margin with test\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 12:21
S27 4	0	S272 and (power with control\$4) and (fault with module)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 12:19
S27 3	0	S272 and (power with control\$4) and (fault with signal)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 12:18
S27 2	22	("4773094" "5455931" "5663968" "5675807" "6000040" "6316988" "6385125" "6617872" "6856926" "20040249913" "20050080887"). pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 12:17
S27 1	0	"6546507".pn. and (power with control\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 12:13
S26 3	0	"6546507".pn. and (power with control)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 12:03

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S27 0		"20030101020".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 11:51
S20 5	7	S200 and (mask\$3 near2 signal)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 11:51
S26 9	1	10/606715 and (margin with test\$3 with system)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 11:24
S26 2	1	10/606715 and (hardware with monitor with transmit\$3 with fault with signal with fault with bypass)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 11:23
S26 8	8	(temperature with monitor\$3 with diode) and (margin with test\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 10:09
S25 8	7	S257 and (more with receiv\$3 with signal)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/29 10:06
S26 4	2	"20030101020".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/28 21:31
S26 0	7	S258 and monitor\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:36
S25 9	4	S258 and bypass	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:36
S25 7	7	S255 and (frequency voltage temperature)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:31

S25	4	S255 and (parameter with	US-PGPUB;	OR	ON	2006/08/26 19:29
6		(frequency voltahe temperature))	USPAT; EPO; JPO; DERWENT; IBM_TDB			
S25 5	7	S254 and (operat\$3 with parameter)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:29
S25 4	7	S253 and (signal with (indicat\$3 identif\$4)) and server and threshold	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:28
S25 2	7	S250 and (signal with (indicat\$3 identif\$4)) and server	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:27
S25 1	0	S250 and (signal with (indicat\$3 identif\$4)) and sever	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:03
S25 0	12	(test\$3 with component with electronic) and (margin with test\$3) and ((indicat\$4 identif\$4) with fault) and pass and fail	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:03
S24 9	12	S246 and (signal with (indicat\$3 identif\$4))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 19:03
S24 8	0	S246 and (signal with pass) and (signal with fail)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:27
S24 7	0	S246 and (siganl with pass) and (signal with fail)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:27
S24 6	12 2:01:03 PM	(test\$3 with component with electronic) and (margin with test\$3) and ((indicat\$4 identif\$4) with fault) and pass and fail	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:26

8/29/06 2:01:03 PM

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S23 6	16	(test\$3 with component with electronic) and (margin with test\$3) and ((indicat\$4 identif\$4) with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:22
S24 5	0	S243 and (fault with mask\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:18
S24 4	0	S243 and (fault with module)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:18
S24 3	3	S242 and (signal with (indicat\$4 identif\$4) with fail)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:18
S24 2	4	margin and (test\$3 with electronic with component) and (signal with (indicat\$4 identif\$4) with pass)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:17
S24 1	0	margin and (test\$3 with electronic with component) and (signbal with (indicat\$4 identif\$4) with pass)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:16
S24 0	0	margin and (test\$3 with electronic with component) and ((indicat\$4 identif\$4) with pass with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:16
S23 9	0	margin and (test\$3 with electronic with component) and (signal with (indicat\$4 identif\$4) with pass with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:14
S23 8	0	(margin with test\$3) and (electronic with component) and (signal with (indicat\$4 identif\$4) with pass with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:14
S23 7	7	S236 and (signal with (indicat\$4 identif\$4) with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 18:13

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S23 5	7	(test\$3 with component with electronic) and (margin with mode) and ((indicat\$4 identif\$4) with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 17:36
S23 4	4	(test\$3 with component with electronic) and (operating with margin with mode) and ((indicat\$4 identif\$4) with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR /	ON	2006/08/26 17:34
S23 3	4	(test\$3 with component with electronic) and (operating with margin with mode) and (signal with (indicat\$4 identif\$4) with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 17:34
S22 8	13	(test\$3 with component with electronic) and (configur\$3 with signal) and (signal with (indicat\$4 identif\$4) with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 17:14
S23 2	0	S228 and (operating with margin with mode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 17:13
S23 1	0	S228 and (absence with margine with test\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 17:13
S23 0	0	S228 and (signal with (indicat\$4 identif\$4) with absence with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 17:12
S22 9	0	(test\$3 with component with electronic) and (configur\$3 with signal) and (signal with (indicat\$4 identif\$4) with absence with fault)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 17:09
S22 7	3	(test\$3 with component with electronic) and ((configur\$3 with signal) same ((indicat\$4 identif\$4) with fault))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 17:05
S22 6	5	(test\$3 with component with electronic) and ((mask with signal) same ((indicat\$4 identif\$4) with fault))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 16:16

S22 5	1	((test\$3 with component with electronic) same (mask with signal)) and (((indicat\$4 identif\$4) with fault))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 16:13
S22 4	4	((test\$3 with component with electronic) same (margin near2 test\$3)) and (((indicat\$4 identif\$4) with fault))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 16:12
S22 0	7	((test\$3 with component with electronic) same (margin\$3 near2 test\$3)) and (((indicat\$4 identif\$4) with fault))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 16:10
S22 3	6	S220 and (generat\$3 with signal)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 16:02
S22 2	0	S220 and (configur\$4 with signal)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 16:02
S22 1	0	S220 and (configured with signal)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 16:01
S21 9	0	(test\$3 with component with electronic) and (margin\$3 near2 test\$3) and ((configur\$3 with signal) same ((indicat\$4 identif\$4) with fault))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 15:59
S20 2	5	S200 and (mask\$3 near2 signal) and (fault near2 module)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/26 15:52